

**Notice of References Cited**

Application/Control No.

09/832,167

Applicant(s)/Patent Under  
Reexamination  
TSUTSUI ET AL

Examiner

Michael J. Moyer

Art Unit

2675

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0175887 A1	11-2002	Yamazaki, Suguru	345/87
	B	US-6,057,820	05-2000	Irwin, Dean S.	345/96
	C	US-6,137,481	10-2000	Phillipps, John Quentin	345/173
	D	US-6,018,331	01-2000	Ogawa, Yasunori	345/99
	E	US-6,429,840 B1	08-2002	Sekiguchi, Kanetaka	345/88
	F	US-6,522,319 B1	02-2003	Yamazaki, Suguru	345/103
	G	US-5,867,140	02-1999	Rader, Sheila M.	345/98
	H	US-5,881,299	03-1999	Nomura et al.	713/324
	I	US-5,710,576	01-1998	Nishiyama et al.	345/169
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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